

Description

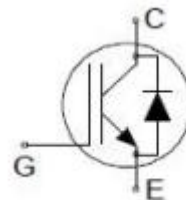
MLG15T65FUL is obtained by advanced Trench Field Stop (T-FS) technology which is characteristic with low $V_{CE(sat)}$, optimized switching performance and low gate charge Q_g . The IGBT is suitable device for BLDC, UPS, and low $V_{CE(sat)}$ applications.

General Features

- ① 650V Breakdown Voltage
- ② Fast Switching
- ③ Low $V_{CE(sat)}$, typ=1.4V@ $I_C=15A$ and $T_C=25^\circ C$
- ④ Positive temperature coefficient
- ⑤ Fast recovery anti-parallel diode
- ⑥ RoHS product

Application

- ① Air condition
- ② UPS
- ③ PFC
- ④ Motor drives



Schematic diagram



TO-220F

Package Marking And Ordering Information:

Device Marking	Ordering Codes	Package	Product Code	Packing
MLG15T65FUL	MLG15T65FUL	TO-220F	G15T65FUL	Tube

Absolute Maximum Ratings:

Symbol	Parameter	Value	Units
V_{CES}	Collector-Emitter Voltage	650	V
I_C	Collector Current @ $T_C=25^\circ C$	30	A
	Collector Current @ $T_C=100^\circ C$	15	A
I_{CM}	Pulsed Collector Current, tp limited by T_{Jmax}	60	A
I_F	Diode Continuous Forward Current @ $T_C=25^\circ C$	15	A
	Diode Continuous Forward Current @ $T_C=100^\circ C$	7.5	A
I_{FM}	Diode Maximum Forward Current, limited by T_{Jmax}	30	A
V_{GES}	Gate-Emitter Voltage	± 30	V
P_D	Power Dissipation @ $T_C=25^\circ C$	41	W
T_{Jmax}, T_{stg}	Operating Junction and Storage Temperature Range	175, -55 to 175	$^\circ C$
T_L	Maximum Temperature for Soldering	260	$^\circ C$

Thermal characteristics

Symbol	Parameter	RATINGS	Units
$R_{\theta JC}$	Junction-to-Case (IGBT)	3.6	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Junction-to-Case (Diode)	3.9	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	78	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics (at $T_c = 25^{\circ}\text{C}$, unless otherwise specified)

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
V_{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0\text{V}$, $I_C = 250\mu\text{A}$	650	--	--	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE} = 15\text{V}, I_C = 15\text{A}$ $T_J = 25^{\circ}\text{C}$ $T_J = 125^{\circ}\text{C}$ $T_J = 175^{\circ}\text{C}$	-- -- --	1.40 1.60 1.70	1.80 -- --	V
$V_{GE(TH)}$	Gate Threshold Voltage	$V_{CE} = V_{GE}, I_C = 1\text{mA}$	5.0	5.8	6.5	V
V_F	Diode Forward Voltage	$I_F = 8\text{A}, T_J = 25^{\circ}\text{C}$ $T_J = 125^{\circ}\text{C}$ $T_J = 175^{\circ}\text{C}$	-- -- --	2.00 1.70 1.60	2.60 -- --	V
I_{CES}	Collector-Emitter Leakage Current	$V_{CE} = 650\text{V}$, $V_{GE} = 0\text{V}$	--	--	15	μA
$I_{GES(F)}$	Gate-Emitter Forward Leakage Current	$V_{GE} = +30\text{V}$	--	--	200	nA
$I_{GES(R)}$	Gate-Emitter Reverse Leakage Current	$V_{GE} = -30\text{V}$	--	--	-200	nA

Pulse width $t_p \leq 300\mu\text{s}$, $\delta \leq 2\%$

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GE} = 0\text{V}$ $V_{CE} = 25\text{V}$ $f = 1.0\text{MHz}$	--	892	--	pF
C_{oss}	Output Capacitance		--	43	--	
C_{rss}	Reverse Transfer Capacitance		--	10	--	
Q_G	Gate charge	$V_{CC} = 520\text{V}$ $I_{CE} = 15\text{A}$ $V_{GE} = 15\text{V}$	--	44	--	nC
Q_{GC}	Gate-emitter charge		--	13	--	
Q_{GE}	Gate-collector charge		--	18	--	
$I_{C(SC)}$	Short circuit collector current Max.1000 short circuits, Times between short circuits: $\geq 1.0\text{s}$	$V_{GE} = 15.0\text{V}, V_{CC} \leq 400\text{V}$, $t_{SC} \leq 3\mu\text{s}, T_J \leq 175^{\circ}\text{C}$		100		A

IGBT Switching Characteristics(at $T_J=25^{\circ}\text{C}$)

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-on Delay Time	$I_C=15\text{A}$ $V_{CE}=400\text{V}$ $V_{GE}=15\text{V}$ $R_G=5\Omega$ $T_J=25^{\circ}\text{C}$ Inductive Load	--	11	--	ns
t_r	Rise Time		--	14	--	
$t_{d(off)}$	Turn-Off Delay Time		--	99	--	
t_f	Fall Time		--	66	--	
E_{on}	Turn-On Switching Loss		--	0.21	--	mJ
E_{off}	Turn-Off Switching Loss		--	0.26	--	
E_{ts}	Total Switching Loss		--	0.47	--	

IGBT Switching Characteristics(at $T_J=175^{\circ}\text{C}$)

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-on Delay Time	$I_C=15\text{A}$ $V_{CE}=400\text{V}$ $V_{GE}=15\text{V}$ $R_G=5\Omega$ $T_J=175^{\circ}\text{C}$ Inductive Load	--	12	--	ns
t_r	Rise Time		--	15	--	
$t_{d(off)}$	Turn-Off Delay Time		--	145	--	
t_f	Fall Time		--	125	--	
E_{on}	Turn-On Switching Loss		--	0.26	--	mJ
E_{off}	Turn-Off Switching Loss		--	0.35	--	
E_{ts}	Total Switching Loss		--	0.61	--	

Diode Characteristics(at $T_J=25^{\circ}\text{C}$)

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
T_{rr}	Reverse Recovery Time	$I_F=8\text{A}$, $di/dt=200\text{A}/\mu\text{s}$, $T_J=25^{\circ}\text{C}$	--	58	--	ns
Q_{rr}	Reverse Recovery Charge		--	168	--	nC
I_{rrm}	Reverse Recovery Current		--	4.2	--	A
T_{rr}	Reverse Recovery Time	$I_F=15\text{A}$, $di/dt=200\text{A}/\mu\text{s}$, $T_J=25^{\circ}\text{C}$	--	72	--	ns
Q_{rr}	Reverse Recovery Charge		--	214	--	nC
I_{rrm}	Reverse Recovery Current		--	5.2	--	A

Diode Characteristics(at $T_J=175^{\circ}\text{C}$)

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
T_{rr}	Reverse Recovery Time	$I_F=8\text{A}$, $di/dt=200\text{A}/\mu\text{s}$, $T_J=175^{\circ}\text{C}$	--	110	--	ns
Q_{rr}	Reverse Recovery Charge		--	620	--	nC
I_{rrm}	Reverse Recovery Current		--	8.5	--	A
T_{rr}	Reverse Recovery Time	$I_F=15\text{A}$, $di/dt=200\text{A}/\mu\text{s}$, $T_J=175^{\circ}\text{C}$	--	140	--	ns
Q_{rr}	Reverse Recovery Charge		--	880	--	nC
I_{rrm}	Reverse Recovery Current		--	10.2	--	A

Characteristics Curves

Figure 1. Forward Bias Safe Operating Area for TO220F

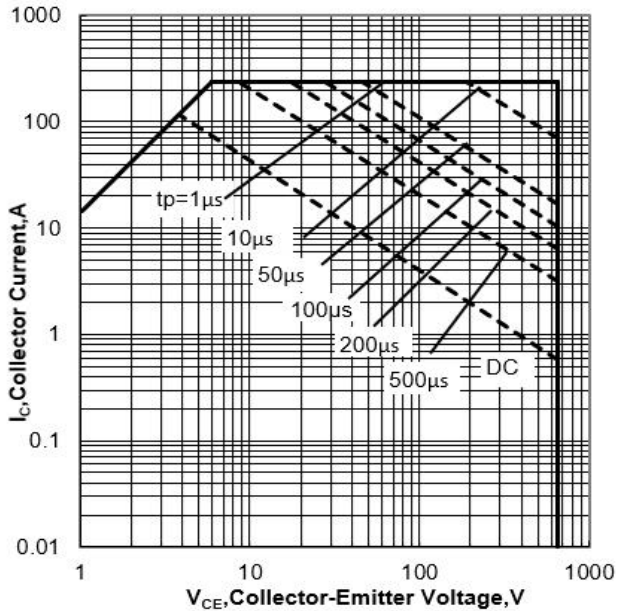


Figure 2. Power Dissipation vs Case Temperature for TO220F

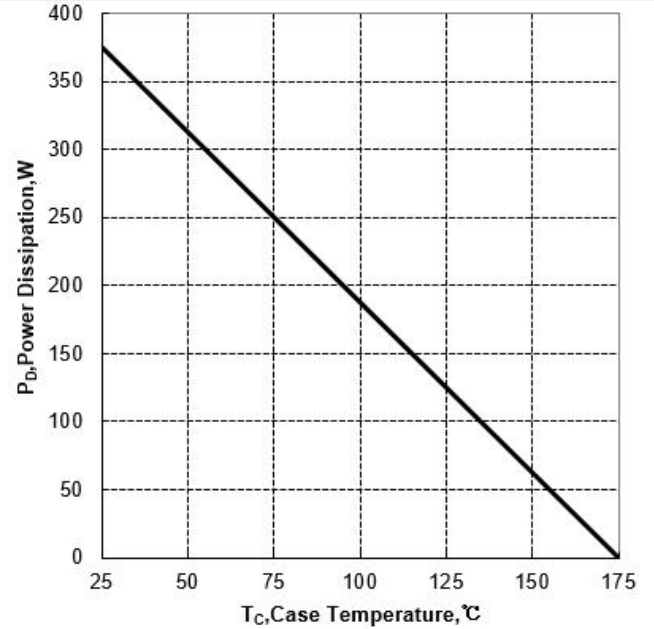


Figure 3. Collector Current vs Case Temperature for TO220F

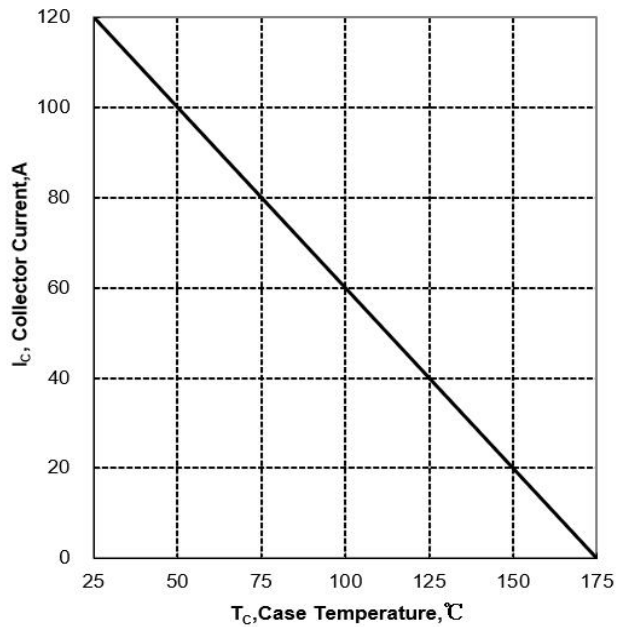


Figure 4. Typical Collector-Emitter Saturation Voltage vs Junction Temperature

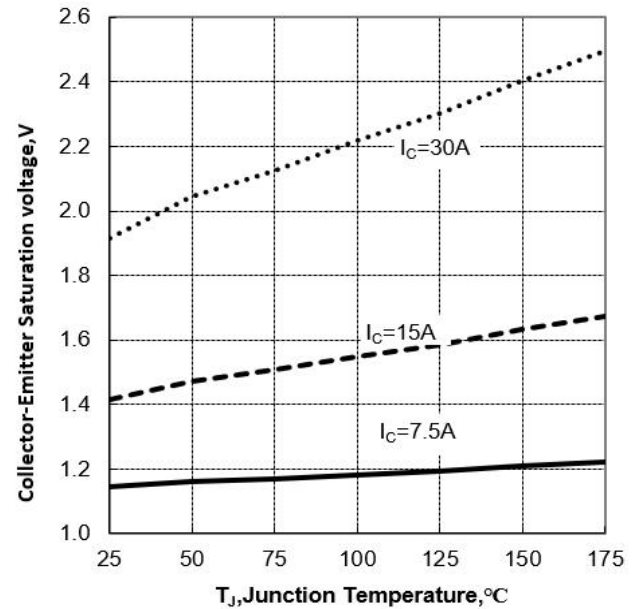


Figure 5. Typical Output Characteristics ($T_J=25^\circ\text{C}$)

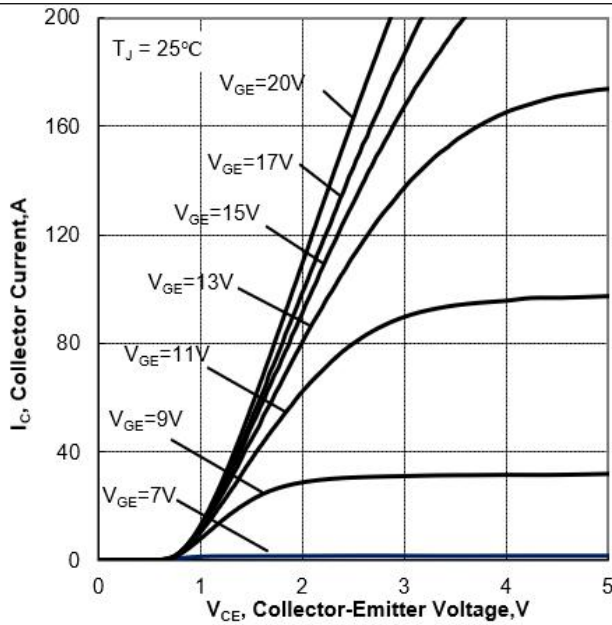


Figure 6. Typical Output Characteristics ($T_J=175^\circ\text{C}$)

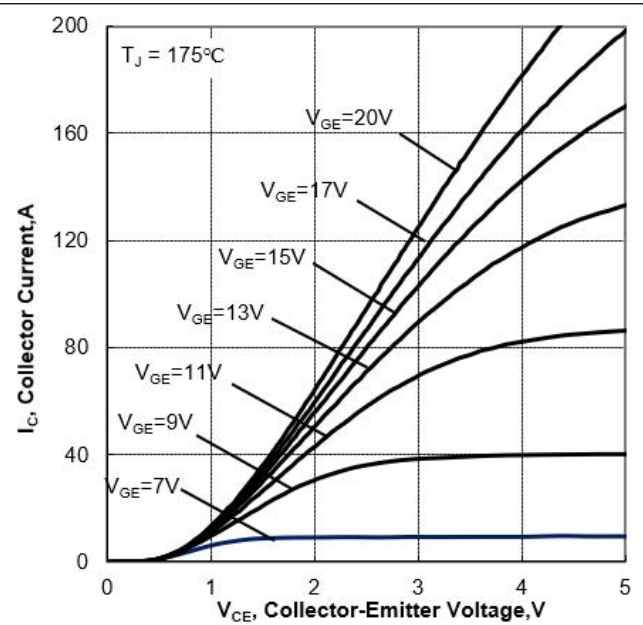


Figure 7. Typical Transfer Characteristics

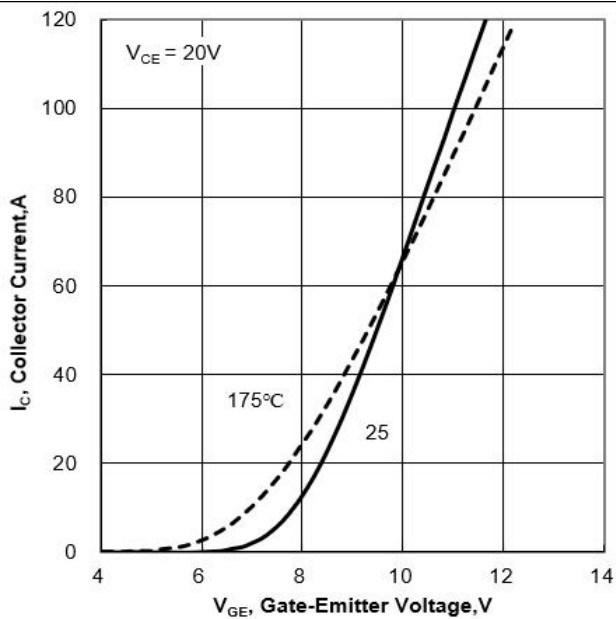


Figure 8. Typical Gate-Emitter Threshold Voltage vs Junction Temperature

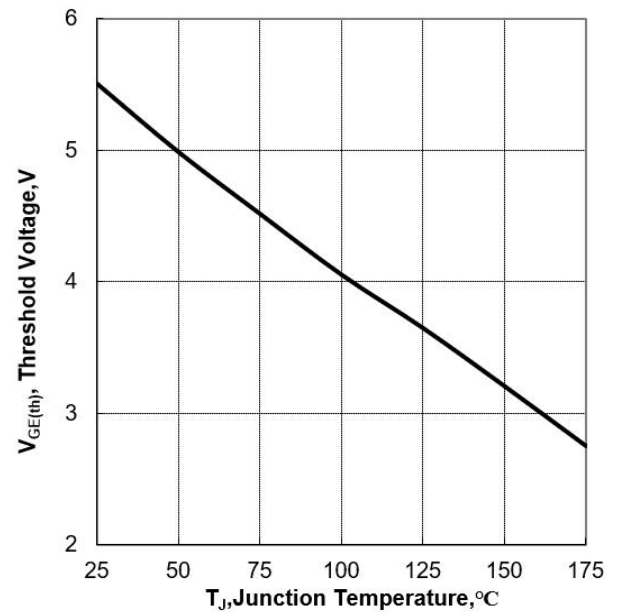


Figure 9. Typical Switching Times vs Gate Resistor
($T_J=25^{\circ}\text{C}$, $V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$, $I_C=15\text{A}$)

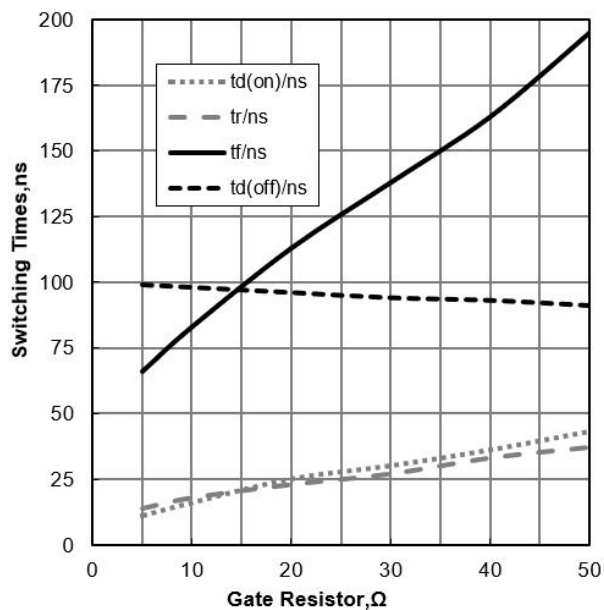


Figure 10. Typical Switching Energy vs Gate Resistor
($T_J=25^{\circ}\text{C}$, $V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$, $I_C=15\text{A}$)

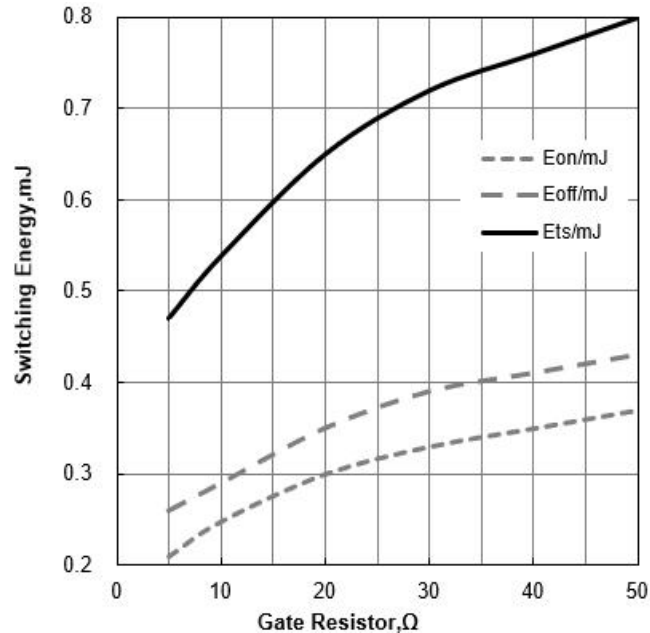


Figure 11. Typical Switching Times vs Junction Temperature
($V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$, $I_C=15\text{A}$)

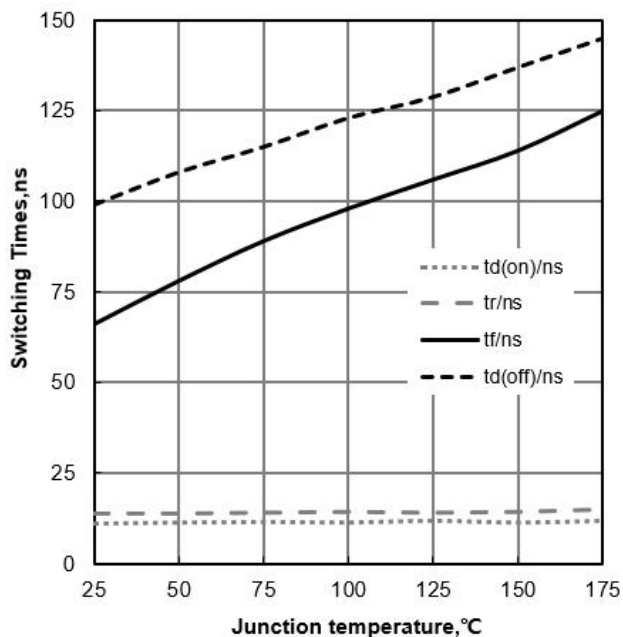


Figure 12. Typical Switching Energy vs Junction Temperature
($V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$, $I_C=15\text{A}$)

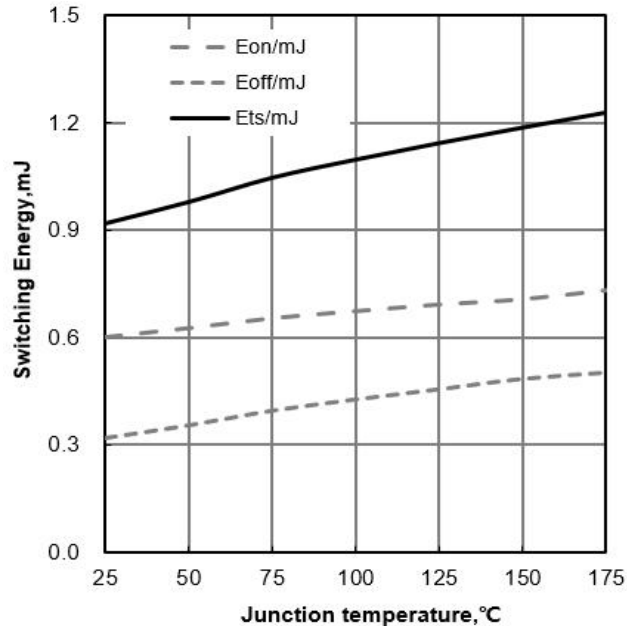


Figure 13. Typical Switching Times vs Collector Current
($T_J=25^{\circ}\text{C}$, $V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$)

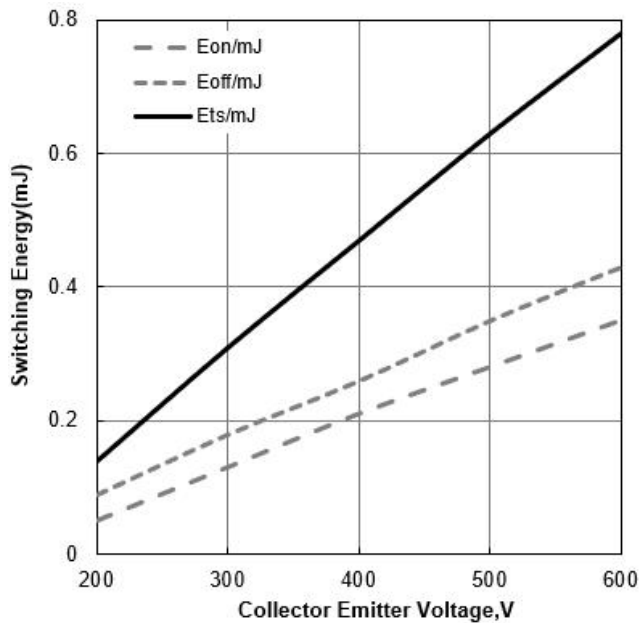


Figure 14. Typical Switching Energy vs Collector Current
($T_J=25^{\circ}\text{C}$, $V_{CE}=400\text{V}$, $V_{GE}=15/0\text{V}$)

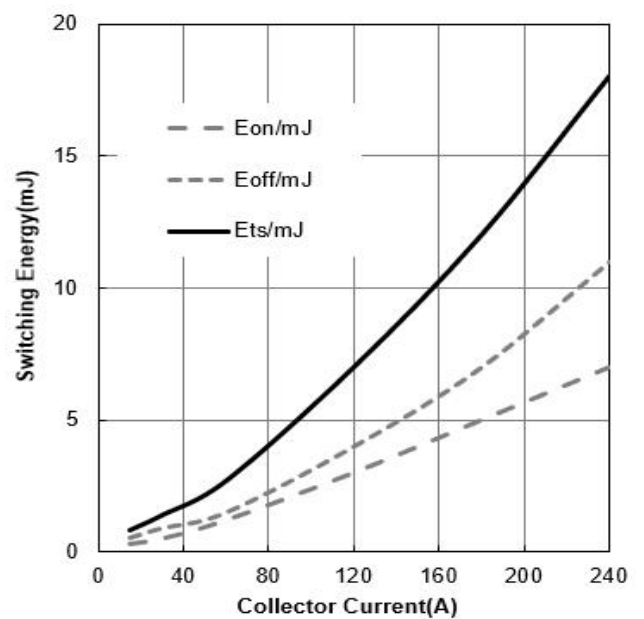


Figure 15. Typical Switching Times vs V_{CE}
($T_J=25^{\circ}\text{C}$, $V_{GE}=15/0\text{V}$, $I_C=15\text{A}$)

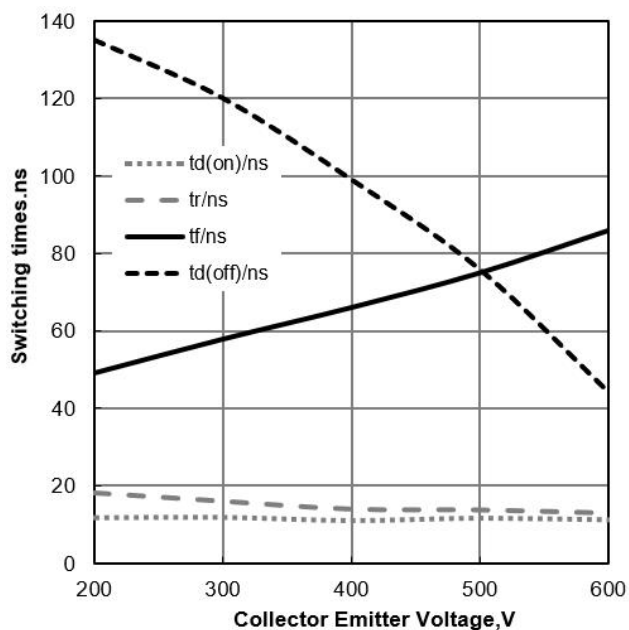


Figure 16. Typical Switching Energy vs V_{CE}
($T_J=25^{\circ}\text{C}$, $V_{GE}=15/0\text{V}$, $I_C=15\text{A}$)

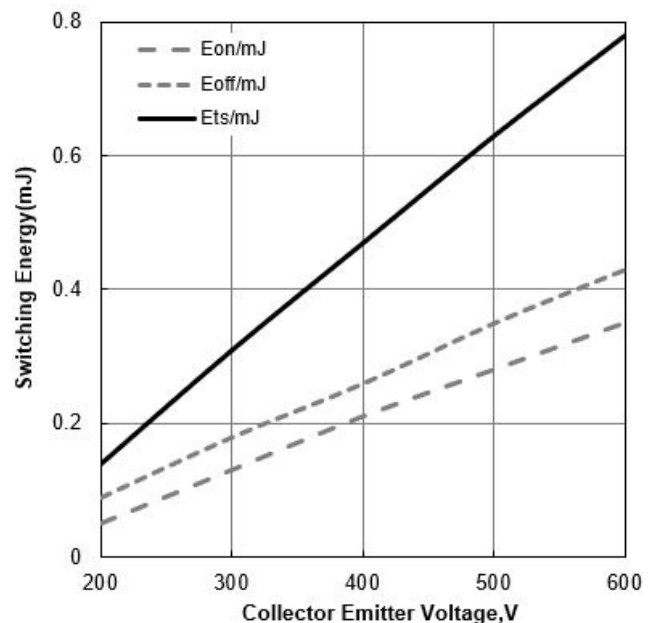


Figure 17. Typical Gate Charge

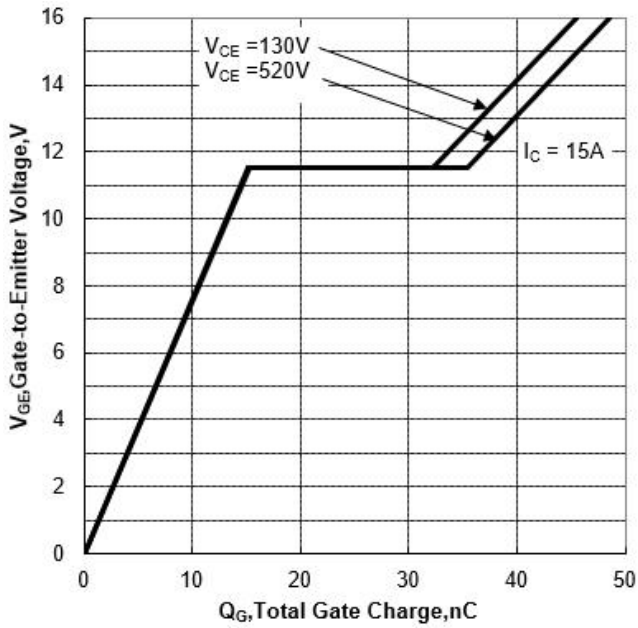


Figure 18. Typical Capacitance vs Collector- Emitter Voltage

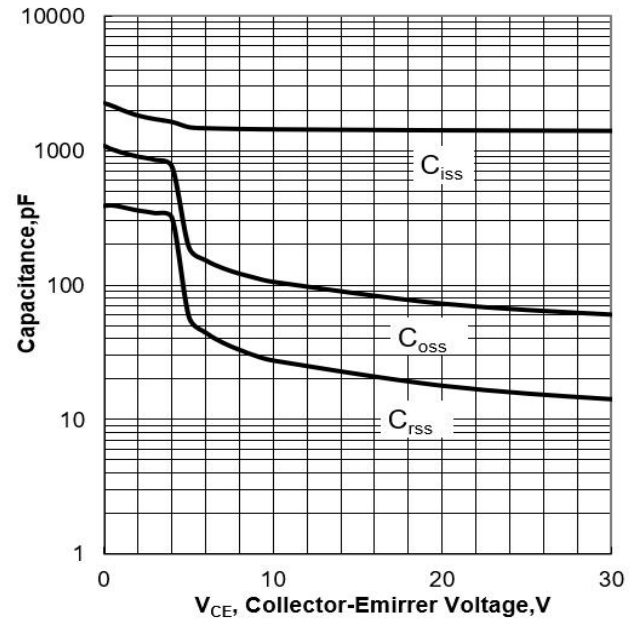


Figure 19. IGBT Transient Thermal Impedance vs Pulse Width(TO220F)

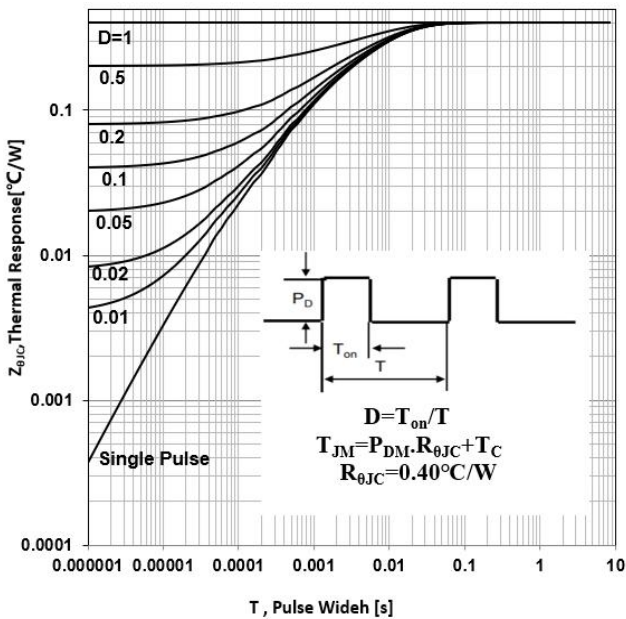


Figure 20. Diode Transient Thermal Impedance vs Pulse Width(TO220F)

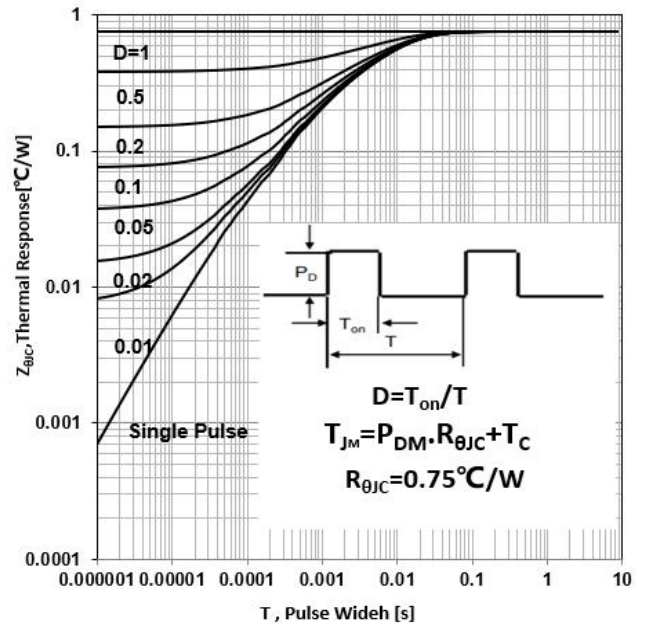
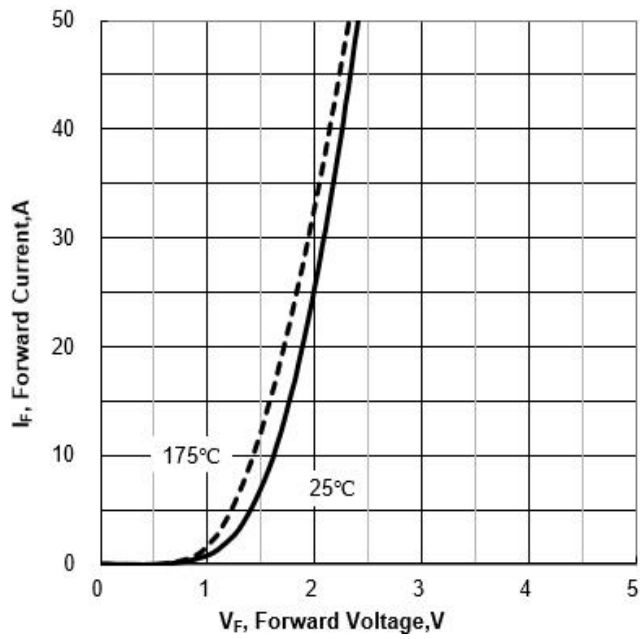


Figure 21. Typical Diode Forward Current vs Forward Voltage



Test Circuit and Waveform

Figure 1. Inductive Switching Test Circuit

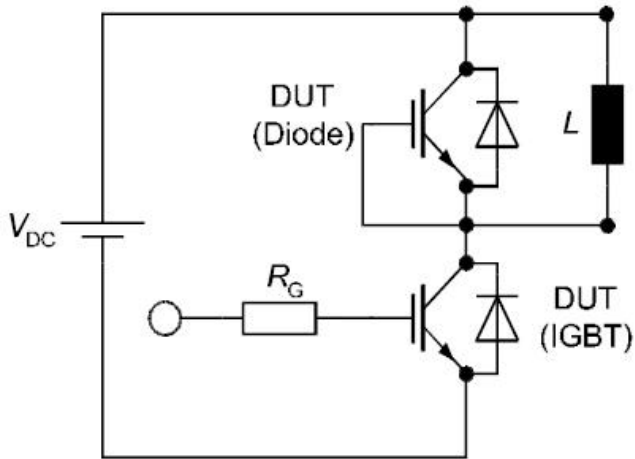


Figure 2. Definition of switching times

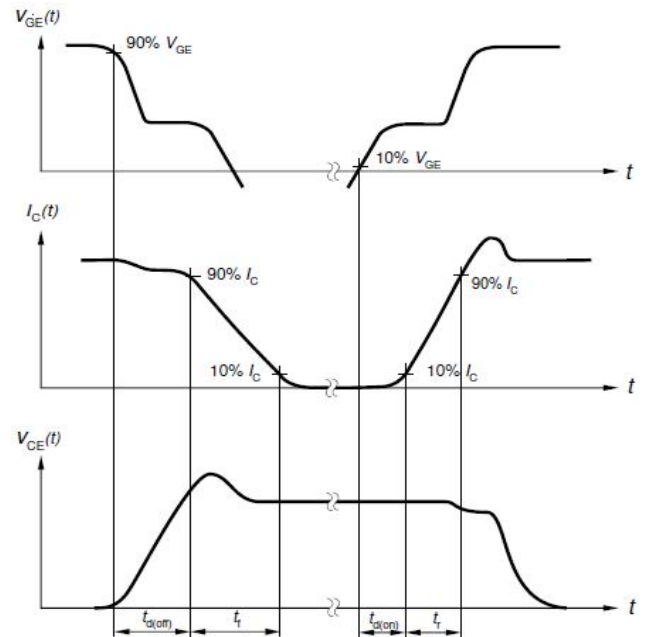


Figure 3. Definition of switching losses

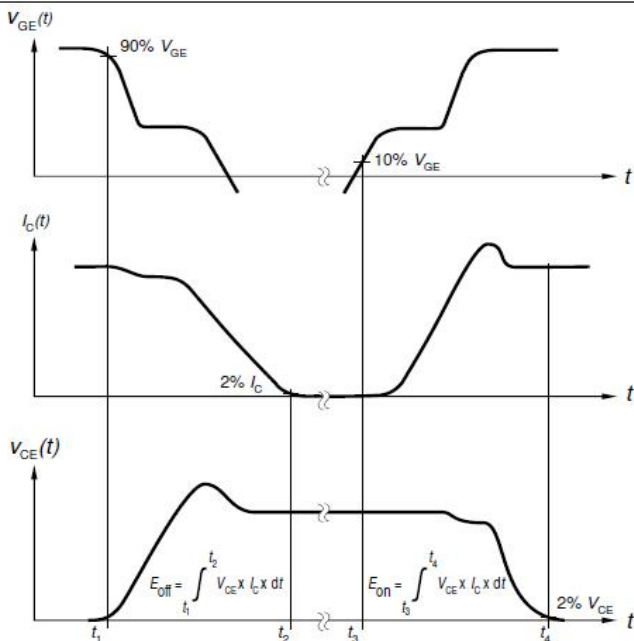
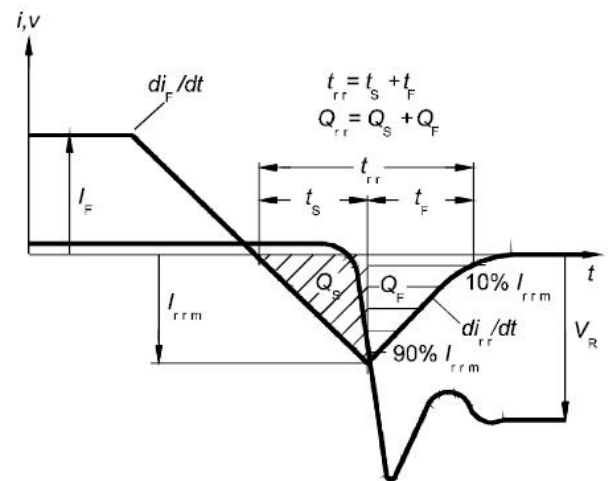
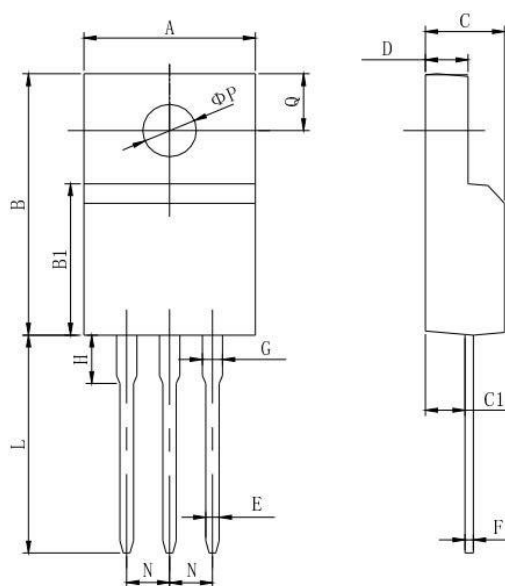


Figure 4. Definition of diode switching characteristics



Package Description



Symbol	Values(mm)	
	MIN	MAX
A	9.60	10.4
B	15.4	16.2
B1	8.90	9.50
C	4.30	4.90
C1	2.10	3.00
D	2.40	3.00
E	0.60	1.00
F	0.30	0.60
G	1.12	1.42
H	3.40	3.80
	1.60	2.90
L	12.0	14.0
N	2.34	2.74
Q	3.15	3.55

TO-220F Package



迈诺斯科技

MLG15T65FUL

NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

CONTACT:

深圳市迈诺斯科技有限公司（总部）

地址：深圳市福田区华富街道田面社区深南中路4026号田面城市大厦22B-22C

邮编：518025

电话：0755-83273777